



#7/B
48-03
SP

B

DE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: F.E. O'Donnell, Jr.
SERIAL NO: 09/741,132
FILED: Dec. 19, 2000
FOR: Method and Apparatus for
Improved PRK Accuracy

GAU: 3739
EXAMINER: D.M. Shay
St. Louis, Missouri
Date: January 14, 2003
DN: 6831

I hereby certify that this correspondence is being deposited with the
U.S. Postal Service as first class mail in an envelope addressed to:
Assistant Commissioner for Patents, Washington, D.C. 20231 on

[Handwritten signature] 1-15-03
Attorney
Date of Signature 1-15-03

Hon. Commissioner for Patents and Trademarks
Washington, DC 20231

AMENDMENT UNDER 37 C.F.R. §1.312

Sir:

This is in response to the Notice of Allowance dated December 30, 2002.

Initially, enclosed are corrected drawings, in addition to a letter to the
Patent Office draftsman, relating to the drawings.

✓ In the application specification, page 6, line 21, through page 7, line 3,
delete the Fig. 8 and Fig. 9 descriptions, and add the following:

-- Fig. 8a shows a front view of a peripheral, superficial stab incision;

Fig. 8b shows a test ablation which straddles the previously applied
incision;

Fig. 8c is a sagittal view disclosing the marked incision;

Fig. 8d shows the marked incision after the dye disappears;

Fig. 9a shows a laser aiming beam focused on the surface of the corneal
stroma following epithelial removal;

Fig. 9b shows the measurement of the aiming beam after a known number
of pulses have been delivered;

Fig. 9c provides a sagittal view of the surface spot size being altered; and

Fig. 9d discloses the depth of the ablation. ---